1.8V Differential 2:1 Mux Input to 1.2V/1.8V 1:6 CML Clock/Data Fanout Buffer / Translator

Multi-Level Inputs w/ Internal Termination Description

The NB7V586M is a differential 1–to–6 CML Clock/Data Distribution chip featuring a 2:1 Clock/Data input multiplexer with an input select pin. The INx/INx inputs incorporate internal 50 Ω termination resistors and will accept differential LVPECL, CML, or LVDS logic levels (see Figure 12). The INx/INx inputs and core logic are powered with a 1.8 V supply. The NB7V586M produces six identical differential CML output copies of Clock or Data. The outputs are configured as three banks of two differential pair. Each bank (or all three banks) have the flexibility of being powered by any combination of either a 1.8 V or 1.2 V supply.

The 16 mA differential CML output structure provides matching internal 50 Ω source terminations and 400 mV output swings when externally terminated with a 50 Ω resistor to V_{CCOX} (see Figure 11).

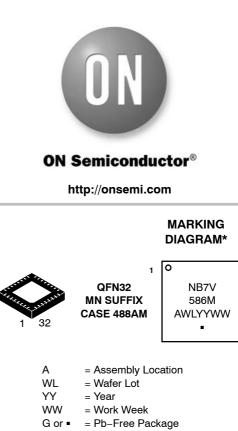
The 1:6 fanout design was optimized for low output skew and minimal jitter and is ideal for SONET, GigE, Fiber Channel, Backplane and other Clock/Data distribution applications operating up to 6 GHz or 10 Gb/s typical. The V_{REFAC} reference outputs can be used to rebias capacitor-coupled differential or single-ended input signals.

The NB7V586M is offered in a low profile 5x5 mm 32–pin Pb–Free QFN package. Application notes, models, and support documentation are available at www.onsemi.com.

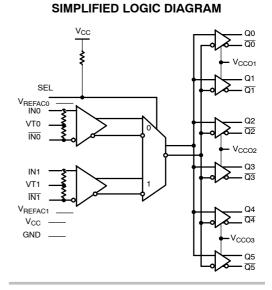
The NB7V586M is a member of the GigaCommTM family of high performance clock products.

Features

- Maximum Input Data Rate > 10 Gb/s Typical
- Data Dependent Jitter < 10 ps
- Maximum Input Clock Frequency > 6 GHz Typical
- Random Clock Jitter < 0.8 ps RMS, Max
- Low Skew 1:6 CML Outputs, 20 ps Max
- 2:1 Multi-Level Mux Inputs
- 175 ps Typical Propagation Delay
- 50 ps Typical Rise and Fall Times
- Differential CML Outputs, 330 mV Peak-to-Peak, Typical
- Operating Range: $V_{CC} = 1.71$ V to 1.89 V
- Operating Range: V_{CCO}x = 1.14 V to 1.89 V
- Internal 50 Ω Input Termination Resistors
- V_{REFAC} Reference Output
- QFN32 Package, 5 mm x 5 mm
- -40°C to +85°C Ambient Operating Temperature
- These are Pb–Free Devices



*For additional marking information, refer to Application Note AND8002/D.



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 7 of this data sheet.

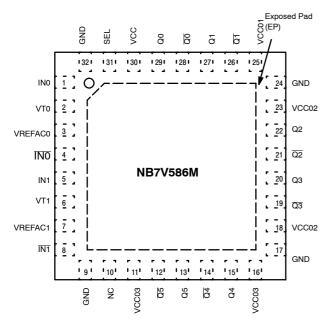


Figure 1. 32-Lead QFN Pinout (Top View)

Table 2. PIN DESCRIPTION

Table 1. INPUT SELECT FUNCTION TABLE

SEL*	CLK Input Selected
0	INO
1	IN1

*Defaults HIGH when left open.

Pin	Name	I/O	Description
1,4 5,8	IN0, <u>IN0</u> IN1, <u>IN1</u>	LVPECL, CML, LVDS Input	Non-inverted, Inverted, Differential Inputs
2,6	VT0, VT1		Internal 100 Ω Center-tapped Termination Pin for IN0/IN0 and IN1/IN1
31	SEL	LVTTL/LVCMOS Input	Input Select pin; LOW for IN0 Inputs, HIGH for IN1 Inputs; defaults HIGH when left open
10	NC	-	No Connect
30	VCC	-	1.8 V Positive Supply Voltage for the Inputs and Core Logic.
25	VCCO1		1.2 V or 1.8 V Positive Supply Voltage for the Q0, Q0, Q1, Q1 CML Outputs
18, 23	VCCO2	-	1.2 V or 1.8 V Positive Supply Voltage for the Q2, Q2, Q3, Q3 CML Outputs
11, 16	VCCO3		1.2 V or 1.8 V Positive Supply Voltage for the Q4, $\overline{Q4}$, Q5, $\overline{Q5}$ CML Outputs
29, 28 27, 26	Q0, <u>Q0</u> Q1, <u>Q1</u>	1.2 V or 1.8 V CML Output	Non-inverted, Inverted Differential Outputs; powered by VCCO1 (Notes 1 and 2).
22, 21 20, 19	Q2, <u>Q2</u> Q3, <u>Q3</u>	1.2 V or 1.8 V CML Output	Non-inverted, Inverted Differential Outputs; powered by VCCO2 (Notes 1 and 2).
15, 14 13, 12	Q4, <u>Q4</u> Q5, <u>Q5</u>	1.2 V or 1.8 V CML Output	Non-inverted, Inverted Differential Outputs; powered by VCCO3 (Notes 1 and 2).
9, 17, 24, 32	GND		Negative Supply Voltage, connected to Ground
3 7	VREFAC0 VREFAC1	_	Output Voltage Reference for Capacitor-Coupled Inputs, only
_	EP	-	The Exposed Pad (EP) on the QFN-32 package bottom is thermally connected to the die for improved heat transfer out of package. The exposed pad must be attached to a heat-sinking conduit. The pad is electrically connected to the die, and must be electrically and thermally connected to GND on the PC board.

 In the differential configuration when the input termination pins (VT0, VT1) are connected to a common termination voltage or left open, and if no signal is applied on INn/INn input, then, the device will be susceptible to self-oscillation. Qn/Qn outputs have internal 50 Ω source termination resistors.

2. All V_{CC} , VCC0x and GND pins must be externally connected to a power supply for proper operation.

Table 3. ATTRIBUTES

Characte	Value		
ESD Protection Human Body Model Machine Model		> 2 kV > 200 V	
Input Pullup Resistor (R _{PU})		75 kΩ	
Moisture Sensitivity (Note 3)		Level 1	
Flammability Rating Oxygen Index: 28 to 34		UL 94 V-0 @ 0.125 in	
Transistor Count	308		
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test			

3. For additional information, see Application Note AND8003/D.

Table 4. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V _{CC}	Positive Power Supply	GND = 0 V		3.0	V
V _{CCOx}	Positive Power Supply	GND = 0 V		3.0	V
V _{IO}	Input/Output Voltage	GND = 0 V	$-0.5 \leq V_{IO} \leq V_{CC} + 0.5$	–0.5 to V _{CC} + 0.5	V
V _{INPP}	Differential Input Voltage IN _x - IN _x			1.89	V
I _{IN}	Input Current Through R_T (50 Ω Resistor)			±40	mA
I _{OUT}	Output Current	Continuous Surge		34 40	mA
IVFREFAC	V _{REFAC} Sink/Source Current			±1.5	mA
T _A	Operating Temperature Range			-40 to +85	°C
T _{stg}	Storage Temperature Range			-65 to +150	°C
θ_{JA}	Thermal Resistance (Junction-to-Ambient) (Note 4)	0 lfpm 500 lfpm	QFN-32 QFN-32	31 27	°C/W °C/W
θ^{JC}	Thermal Resistance (Junction-to-Case) (Note 4)	Standard Board	QFN-32	12	°C/W
T _{sol}	Wave Solder Pb-Free			265	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.4. JEDEC standard multilayer board – 2S2P (2 signal, 2 power) with 8 filled thermal vias under exposed pad.

Table 5. DC CHARACTERISTICS – CML OUTPUT V_{CC} = 1.8 V ±5%, V_{CCO1} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5%
or 1.8 V ±5%, V _{CCO3} = 1.2 V ±5% or 1.8 V ±5%, GND = 0 V, T _A = -40° C to 85°C (Note 5)

Symbol	Character	ristic	Min	Тур	Max	Unit
POWER	SUPPLY CURRENT (Inputs and Out	puts open)		1		
I _{CC} I _{CCO}	Power Supply Current for V _{CC} Power Supply Current for VCCOx	(Inputs and Outputs Open) (Inputs and Outputs Open)		75 95	125 105	mA
CML OU	TPUTS (Note 6)					
V _{OH}	Output HIGH Voltage	V _{CC} = 1.8 V, VCCOx = 1.8 V V _{CC} = 1.8 V, VCCOx = 1.2 V	V _{CCOx} – 40 1760 1160	V _{CCOx} – 20 1780 1180	V _{CCOx} 1800 1200	mV
V _{OL}	Output LOW Voltage	V _{CC} = 1.8 V, VCCOx = 1.8 V V _{CC} = 1.8 V, VCCOx = 1.2 V	V _{CCOx} – 500 1300 700	V _{CCOx} - 400 1400 800	V _{CCOx} - 275 1525 925	mV
DIFFERE	NTIAL INPUTS DRIVEN SINGLE-E	NDED (Note 7) (Figure 6)				
V _{th}	Input Threshold Reference Voltage	Range (Note 8)	1050		V _{CC} – 100	mV
V _{IH}	Single-Ended Input HIGH Voltage		V _{th} + 100		V _{CC}	mV
V _{IL}	Single-Ended Input LOW Voltage		GND		V _{th} – 100	mV
V _{ISE}	Single-Ended Input Voltage (V _{IH} -	V _{IL})	200		1200	mV
V _{REFAC}						
V _{REFAC}	Output Reference Voltage @ 100 μ Inputs, Only	V _{CC} – 550	V _{CC} – 450	V _{CC} – 300	mV	
DIFFERE	NTIAL INPUTS DRIVEN DIFFEREN	ITIALLY (Note 9) (Figures 4 and	17)	•		
V _{IHD}	Differential Input HIGH Voltage (IN, IN)		1100		V _{CC}	mV
V _{ILD}	Differential Input LOW Voltage (IN, IN)		GND		V _{CC} – 100	mV
V _{ID}	Differential Input Voltage (IN, IN) (V _{IHD} - V _{ILD})		100		1200	mV
V _{CMR}	Input Common Mode Range (Differential Configuration, Note 10) (Figure 9)		1050		V _{CC} – 50	mV
I _{IH}	Input HIGH Current IN/IN (VTO / V	T1 Open)	-150		150	μA
IIL	Input LOW Current IN/IN (VTO / VT	1 Open)	-150		150	μA
CONTRO	DL INPUT (SEL Pin)					
V _{IH}	Input HIGH Voltage for Control Pin		V _{CC} x 0.65		V _{CC}	mV
V _{IL}	Input LOW Voltage for Control Pin		GND		V _{CC} x 0.35	mV
I _{IH}	Input HIGH Current		-150	20	+150	μA
IIL	Input LOW Current		-150	5	+150	μA
TERMIN	ATION RESISTORS					
R _{TIN}	Internal Input Termination Resistor	(Measured from INx to VTx)	45	50	55	Ω
	Internal Output Termination Resistor		45	50	55	Ω

board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

5. Input parameters vary 1:1 with V_{CC} and output parameters vary 1:1 with V_{CCOx} . 6. CML outputs (Qn/Qn) have internal 50 Ω source termination resistors and must be externally terminated with 50 Ω to V_{CCOx} for proper operation.

 V_{th}, V_{IH}, V_{IL} and V_{ISE} parameters must be complied with simultaneously.
V_{th} is applied to the complementary input when operating in single–ended mode.
V_{IHD}, V_{ILD}, V_{ID} and V_{CMR} parameters must be complied with simultaneously.
V_{CMR} min varies 1:1 with GND, V_{CMR} max varies 1:1 with V_{CC}. The V_{CMR} range is referenced to the most positive side of the differential invaries 1:1 input signal.

Symbol	Characteristic		Тур	Max	Unit
f _{MAX}	Maximum Input Clock Frequency, $V_{OUTPP} \ge 200 \text{ mV}$	4.0	6.0		GHz
f _{DATAMAX}	Maximum Operating Input Data Rate (PRBS23)	10			Gbps
V _{OUTPP}	$\label{eq:output Voltage Amplitude} \mbox{ (See Figures 4, Note 15)} \qquad f_{in} \leq 4.0 \mbox{ GHz}$	200	330		mV
t _{PLH} , t _{PHL}	$\begin{array}{llllllllllllllllllllllllllllllllllll$	125 125	175	250 300	ps
t _{PLH} TC	Propagation Delay Temperature Coefficient		100		fs/°C
t _{SKEW}	Output – Output Skew (Within Device) (Note 12) Device – Device Skew (t _{pd} Max – t _{pdmin})			30 50	ps
t _{DC}	Output Clock Duty Cycle (Reference Duty Cycle = 50%) $~f_{in} \leq 4.0~GHz$	45	50	55	%
t _{JITTER}			0.2	0.8 10	ps rms ps pk–pk
V _{INPP}	Input Voltage Swing (Differential Configuration) (Note 15)	100		1200	mV
t _r , t _f	Output Rise/Fall Times @ 1 GHz (20% – 80%) $Q_n, \overline{Q_n}$		50	65	ps

Table 6. AC CHARACTERISTICS V_{CC} = 1.8 V ±5%, V_{CCO1} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2} = 1.2 V ±5% or 1.8 V ±5%, V_{CCO2}	
V_{CCO3} = 1.2 V ±5% or 1.8 V ±5%, GND = 0 V, T _A = -40°C to 85°C (Note 11)	

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

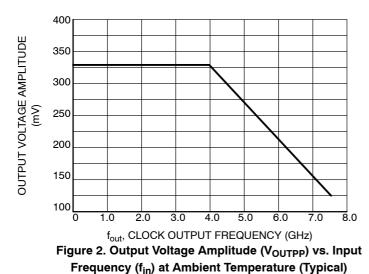
Measured using a 400 mV source, 50% duty cycle clock source. All outputs must be loaded with external 50 Ω to V_{CCOx}. Input edge rates 40 ps (20% – 80%).

12. Skew is measured between outputs under identical transitions and conditions. Duty cycle skew is defined only for differential operation when the delays are measured from cross-point of the inputs to the crosspoint of the outputs.

13. Additive RMS jitter with 50% duty cycle clock signal.

14. Additive Peak-to-Peak data dependent jitter with input NRZ data at PRBS23.

15. Input and output voltage swing is a single-ended measurement operating in differential mode.



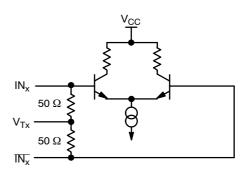
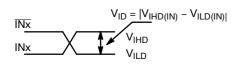
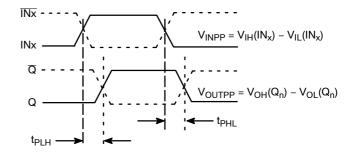


Figure 3. Input Structure









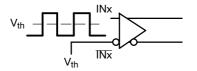
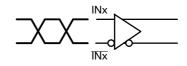


Figure 6. Differential Input Driven Single-Ended





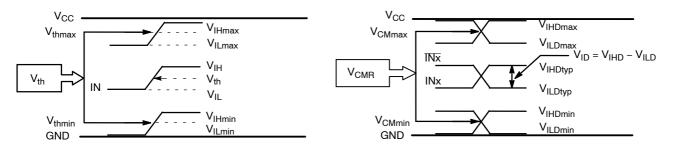




Figure 9. V_{CMR} Diagram

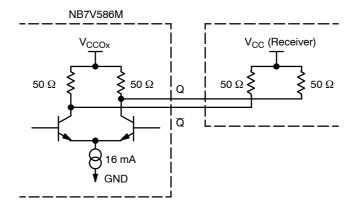
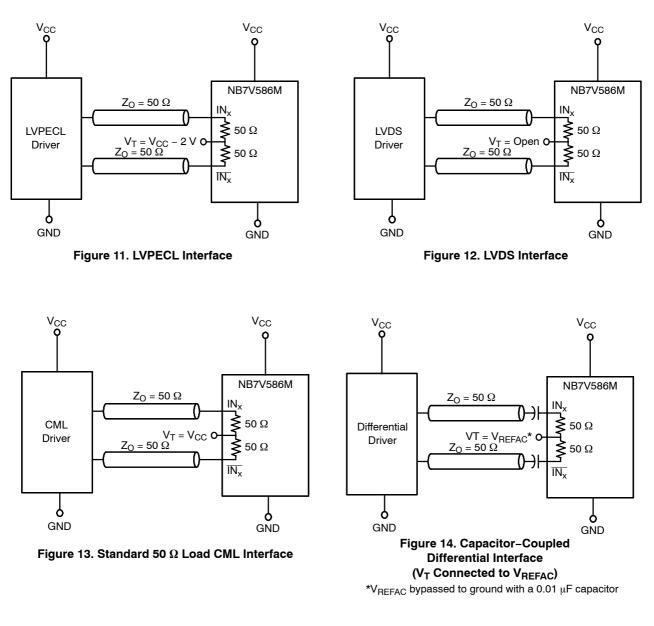


Figure 10. Typical CML Output Structure and Termination

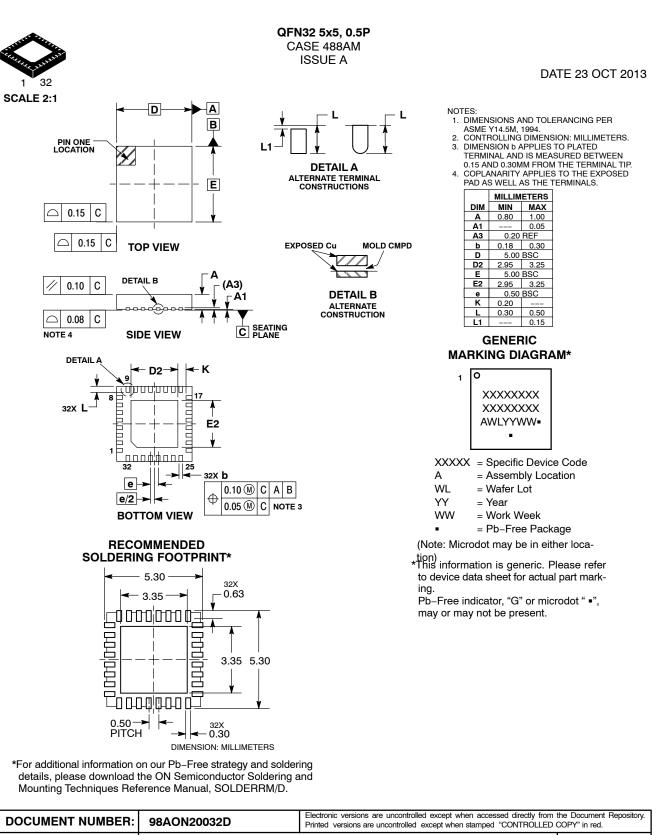


ORDERING INFORMATION

Device	Package	Shipping [†]
NB7V586MMNG	QFN32 (Pb-Free)	74 Units / Rail
NB7V586MMNR4G QFN32 (Pb-Free)		1000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





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DESCRIPTION:

QFN32 5x5 0.5P

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